

Isn't it about time you had your own Digital Microscope?

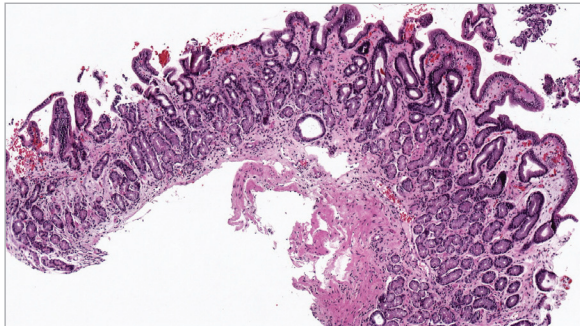
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The uScopeMXII is a small digital desktop microscope you can use in your workplace or home office. It captures images from standard glass slides and sends them to your PC.

You can interactively browse slides with full control of focus, image processing, and location. You can also scan regions of interest creating fully focused image sets.

The industry-standard USB interface makes it simple to plug in and get started. It easily interfaces with your desktop or laptop PC and allows you to view and capture slide images in a wide variety of environments.

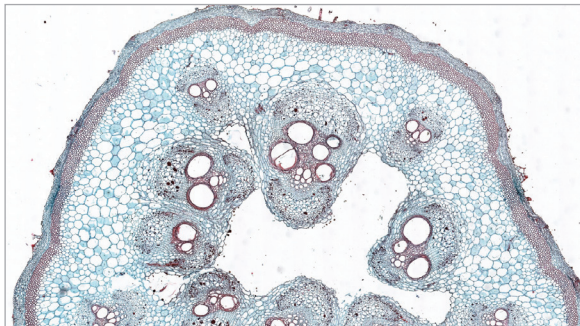
The uScopeMXII is designed and manufactured in the United States.



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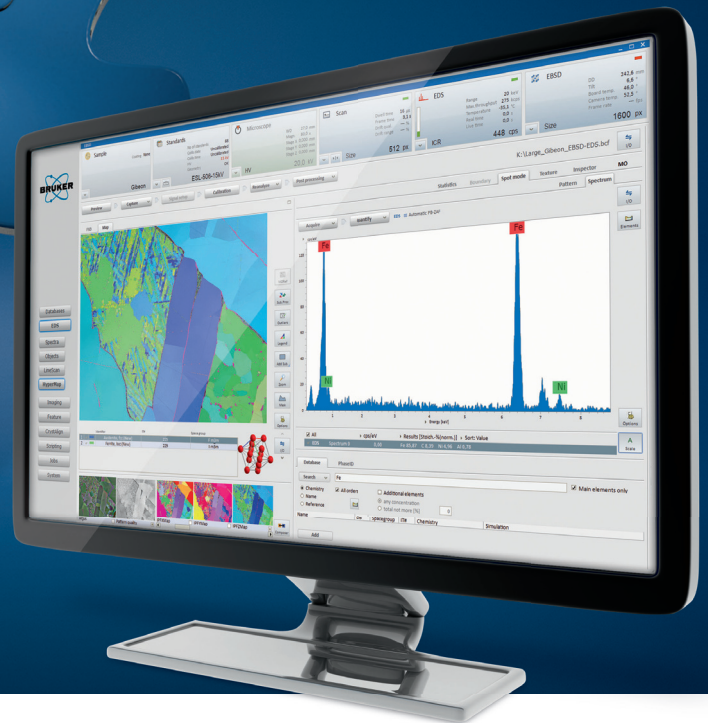


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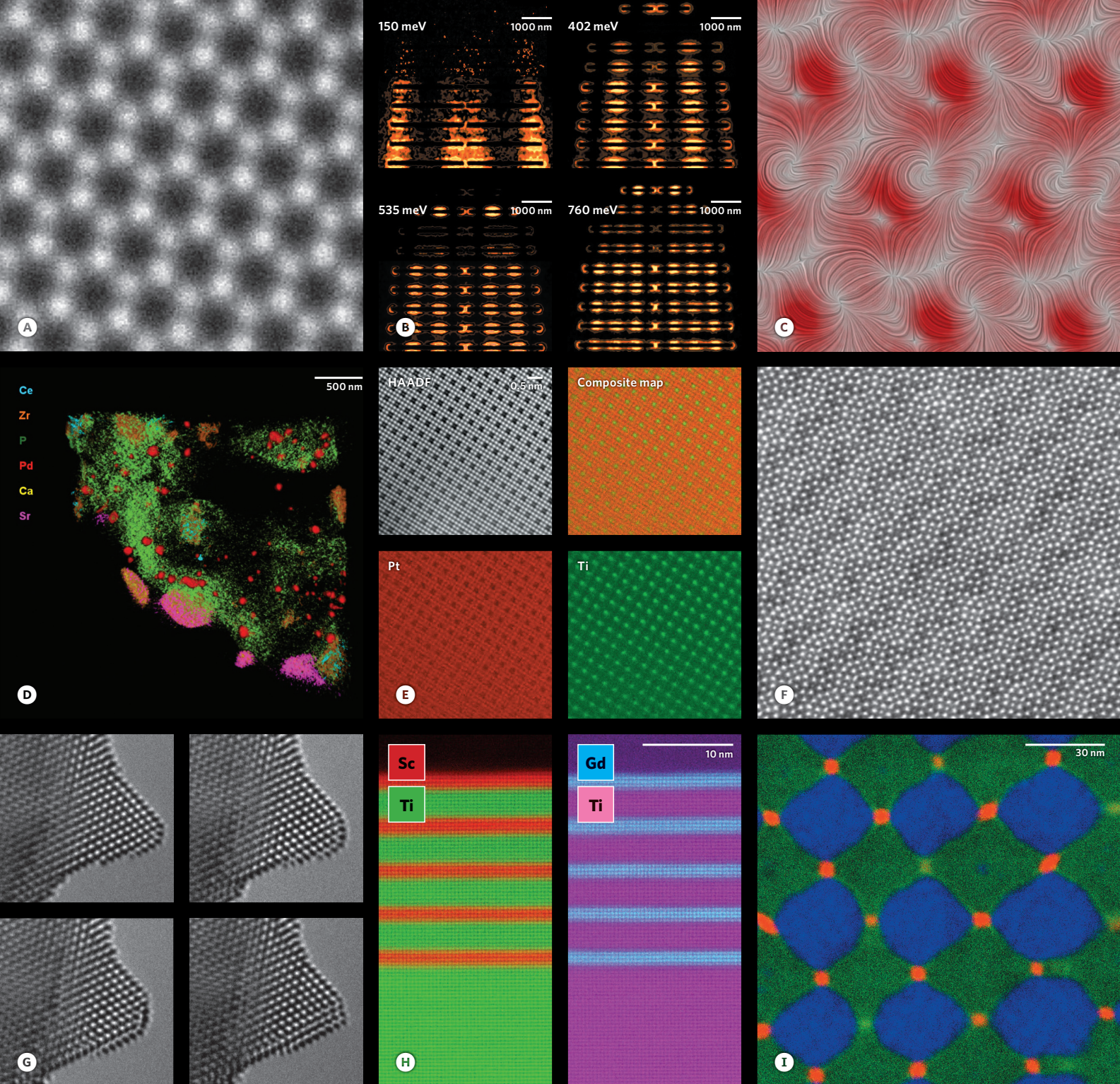
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A: Low-kV HRSTEM imaging of Graphene (80 kV). **B:** Plasmonic imaging of noble metal nanowires. **C:** Atomic electrostatic field visualization in GaN using DPC. **D:** EDS tomography of automotive catalyst. **E:** Atomic EDS mapping. **F:** HRSTEM of (Ba, Sr) Nb₂O₆. Courtesy B. Kabius, Materials Research Institute Penn State. **G:** Dynamic behavior (clockwise) of gold atoms captured with the CETA camera at 25fps. **H:** Atomic EDS mapping. **I:** 4k × 4k EDS map from ALNICO-8. Red: Cu, Blue: Fe, Green: Ni. Sample courtesy of Prof. Hamish Fraser, The Ohio State University, USA.

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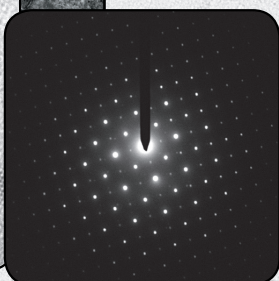
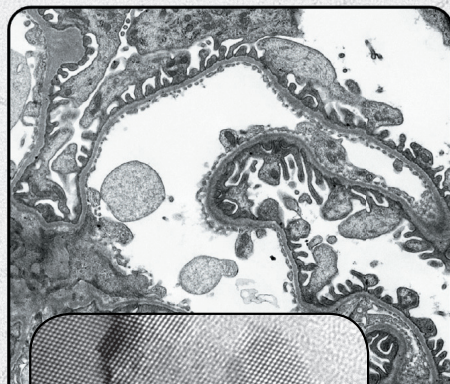
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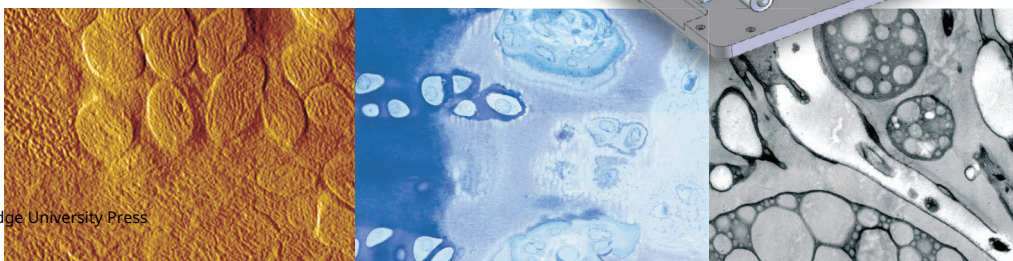
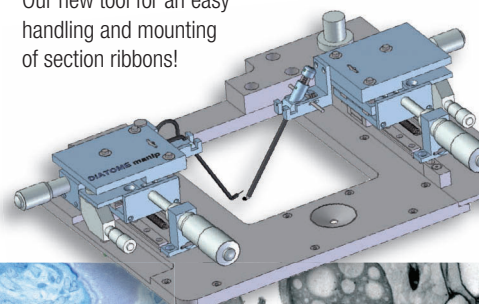
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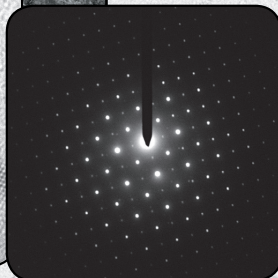
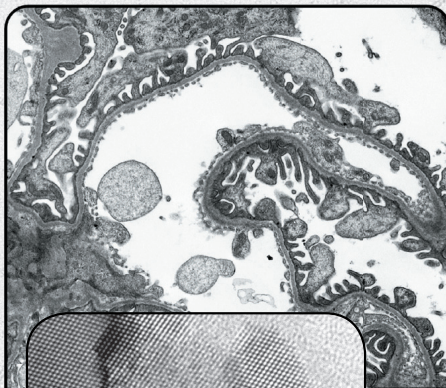
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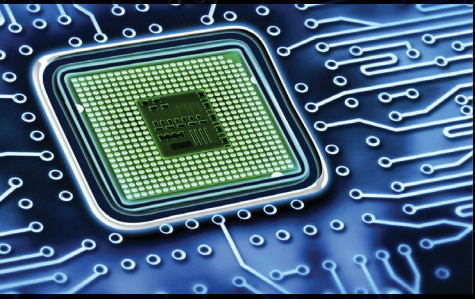
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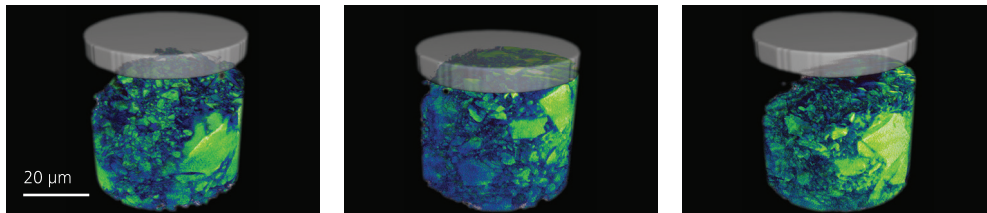
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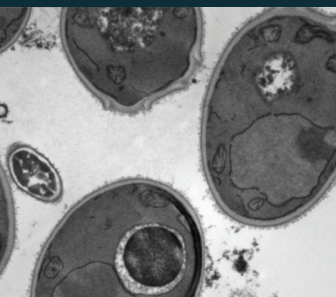
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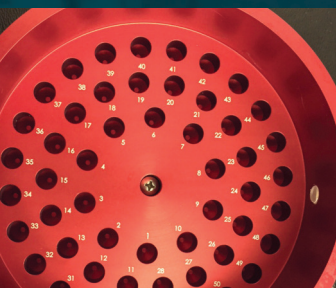
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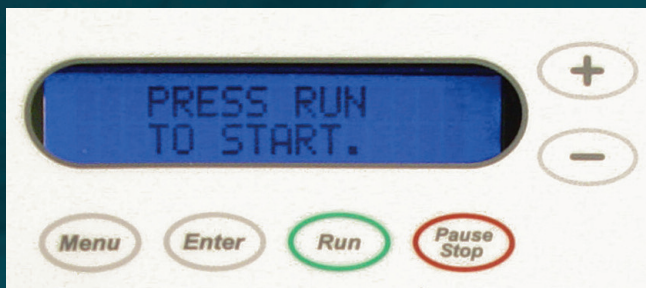
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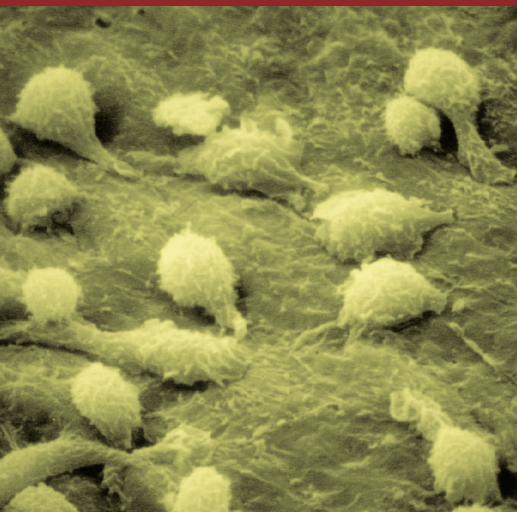
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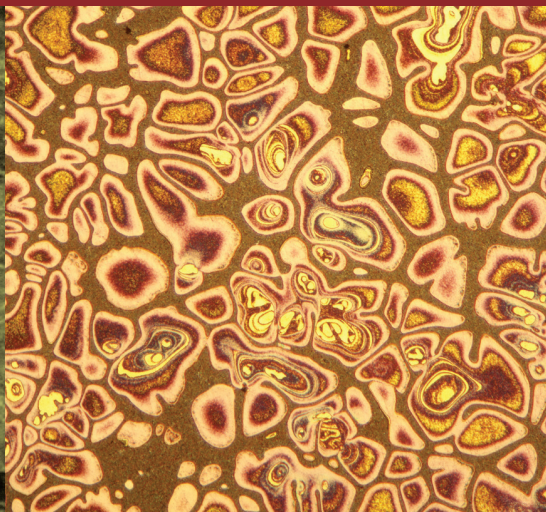
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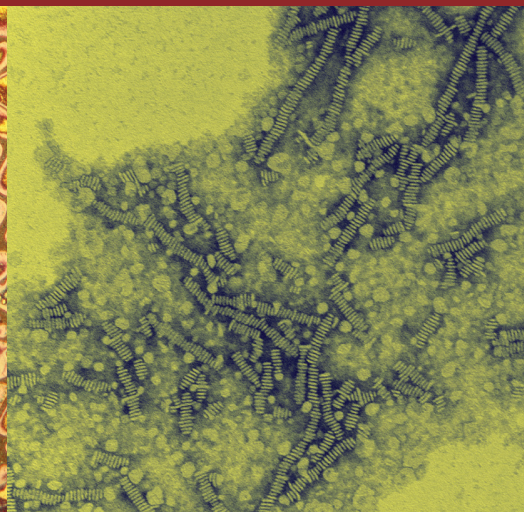
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High Density Lipoprotein (HDL; the good cholesterol carrier) Stacking Together in Solution. W. Gray (Jay) Jerome, Vanderbilt University



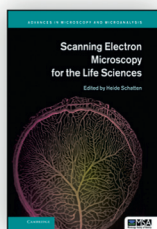
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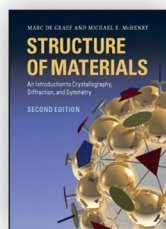
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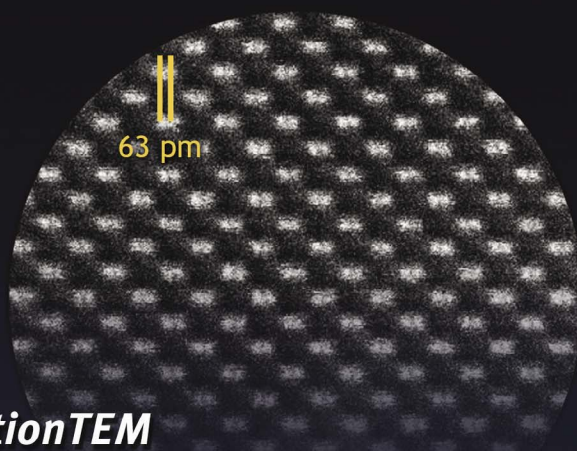
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